

<b>Specification</b>	<b>AXLE195</b>	Rev.: 1	Date: 2014-04-06
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**Oscillator type: SMD (VC)TCXO in 19.8x12.5 mm package**

Parameter	min.	typ.	max.	Unit	Condition
<b>Frequency range</b>	6		190	MHz	Clipped Sine wave
	6		190	MHz	Sine wave
	1		800	MHz	HCMOS
<b>Frequency stability</b>				ppm	
vs. operating temperature range	±0.5 to ±5 See tables 1 & 2			ppm	Option 4 & 5
vs. supply voltage variation		±0.1	±0.3	ppm	V <sub>S</sub> ±5 %
vs. load change			±0.2	ppm	Load ±10 %
Long term (aging) per year			±1	ppm	@+40°C
<b>Frequency adjustment range</b>					
Mechanical (internal trimmer)	±3			ppm	Option 1 = blank
Electronic Frequency Control (EFC)	±5			ppm	Option 1 = "V"
EFC voltage V <sub>C</sub>	0.15	1.65	3.15	V	Option 2 = "3"
	0.5	2.5	4.5	V	Option 2 = "5"
EFC slope ( $\Delta f / \Delta V_C$ )	Positive				
EFC input impedance	100			kΩ	
<b>RF output</b>					
Signal waveform (Note 2)	Clipped Sine wave Sine wave HCMOS				Option 3 = "C" Option 3 = "S" Option 3 = "H"
Load	10 kΩ    10 pF 50 Ω 15 pF				Option 3 = "C" Option 3 = "S" Option 3 = "H"
Amplitude	0.8			V p-p	Option 3 = "C" / 3.3 V
	1.0			V p-p	Option 3 = "C" / 5.0 V
		0		dBm	Option 3 = "S" / 3.3 V
		+10		dBm	Option 3 = "S" / 5.0 V
	According to relevant Logic Standard				Option 3 = "H"
<b>Supply voltage V<sub>S</sub></b>	3.15	3.3	3.45	V	Option 2 = "3"
	4.75	5.0	5.25	V	Option 2 = "5"
<b>Current consumption</b> (Note 3)	2 ~ 30			mA	Option 3 = "C"
	12 ~ 100			mA	Option 3 = "S"
	15 ~ 100			mA	Option 3 = "H"
<b>Enclosure (see drawing) (LxWxH)</b>	20.3x13.0x5.7 max.			mm	Similar to IEC 61837 CO 30
<b>Weight</b>			3	g	
<b>Packing</b>	Tape & Reel				IEC 60286-3

**Notes:**

1. Terminology and test conditions are according to IEC60679-1 and MIL-PRF-55310, unless otherwise stated
2. PECL and LVDS output on request (without EFC function)
3. Depending on frequency and supply voltage
4. All combinations of options might not be available. Please consult factory

### Absolute Maximum Ratings

Parameter	min.	max.	Unit	Condition
Supply Voltage $V_S$	-0.5	$V_S + 10\%$	V	$V_S$ to GND
Control Voltage $V_C$	-0.5	6	V	$V_C$ to GND
Storage Temperature	-55	+105	°C	

### Frequency stability vs. temperature

Option 4	Stability [ppm]
05	±0.5
10	±1.0
15	±1.5
20	±2.0
25	±2.5
30	±3.0
35	±3.5
50	±5.0

Table 1

Lower Temperature		Upper Temperature	
Option 5	T [°C]	Option 5	T [°C]
0	0	A	+50
1	-10	B	+60
2	-20	C	+70
3	-30	D	+75
4	-40	E	+80
		F	+85

Table 2

### Ordering Code

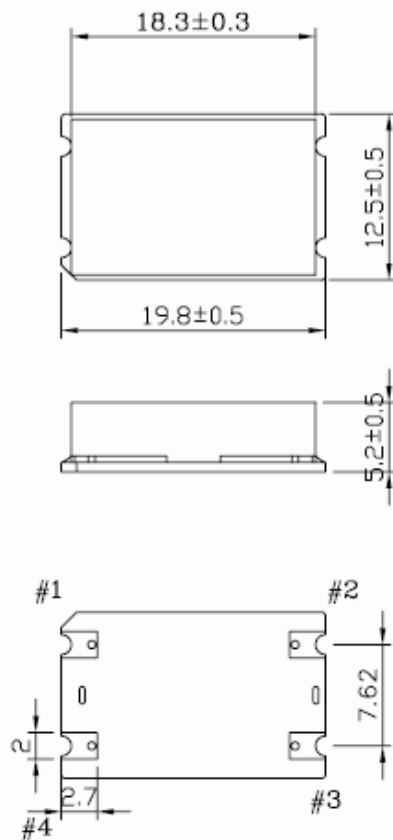
Model	Option 1 [EFC]*	Option 2 [Supply Voltage]	Option 3 [RF output]	Option 4 [Stability]	Option 5 [Temperature range]	Revision	Frequency [MHz]
AXLE195	_ or "V"	3 or 5	C, S, H	Table 1	Table 2	Rev.1	10.000

Example: AXLE195-V-5-S-10-3D\_Rev.1 – 10.000 MHz

### Handling and Testing

Parameter	Procedure	Source
Handling and Testing	Application Note AXAN-011	www.axtal.com
Processing	Application Note AXAN-012	www.axtal.com
Parameter	Procedure	Condition
Electrostatic discharge (ESD)		
THD devices	IEC60749-26	HBM 2000 V
SMD devices	IEC60749-27	MM 200 V
Washable	<input type="checkbox"/> Yes <input checked="" type="checkbox"/> No	
RoHS compliant	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	

## Enclosure drawing



## Pin connections

Pin #	Symbol	Function
1	N.C. or $V_c$	No Connection or Control Voltage (EFC)
2	GND	Ground
3	RF OUT	RF Output
4	$V_s$	Supply Voltage

## Environmental conditions

Test	IEC 60068 Part ...	IEC 60679-1 Clause	MIL-STD-202G Method	MIL-STD-810F Method	MIL-PRF-55310D Clause	Test conditions (IEC)
Sealing tests (if applicable)	2-17	5.6.2	112E		3.6.1.2	Gross leak: Test Qc, Fine leak: Test Qk
Solderability	2-20	5.6.3	208H		3.6.52	Test Ta Method 1
Resistance to soldering heat	2-58		210F		3.6.48	Test Td <sub>1</sub> Method 2 Test Td <sub>2</sub> Method 2
Shock*	2-27	5.6.8	213B	516.4	3.6.40	Test Ea, 3 x per axes 100g, 6 ms half-sine pulse
Vibration, sinusoidal*	2-6	5.6.7.1	201A 204D	516.4-4	3.6.38.1 3.6.38.2	Test Fc, 30 min per axes, 10 Hz - 55 Hz 0,75mm; 55 Hz - 2 kHz, 10g
Vibration, random*	2-64	5.6.7.3	214A	514.5	3.6.38.3 3.6.38.4	Test Fdb
Endurance tests			108A			
- ageing		5.7.1			4.8.35	30 days @ 85°C, OCXO @25°C
- extended aging		5.7.2				1000h, 2000h, 8000h @85°C

Other environmental conditions on request

Data sheet is for information purposes only and may be subject to modifications or may be discontinued without notice.

**Revision History**

<b>Rev.</b>	<b>Drawing</b>	<b>Date</b> [dd.mm.yyyy]	<b>Remarks</b>	<b>Author</b>	<b>Checked</b>
1	D1	01.10.2012	Editorial changes	BN	BN
1	D2	06.04.2014	Environmental conditions updated, editorial changes	HH	HH